Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/786,489	OGIWARA, TOSHIAKI		
Examiner	Art Unit		
Mark Kopec	1751		

SEARCHED					
Class	Subclass	Date	Examiner		
252	511	8/19/2006	M.K.		
252	512				
252	513				
252	514				
525	929				
528	312)	4		

Subclass	Date	Examiner
	8/20/2006	M.K.
	Subclass	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC structure search	8/18/2006	м.к.		
EAST and CAS				
Inv. Name Search		7		